SHORT-WAVE INFRARED PHOTODETECTORS BASED ON COLLOIDAL QUANTUM DOTS JUNE 13TH 2017

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WHY SHORT-WAVE INFRARED DETECTORS BASED ON QDS?

Short wave infrared: 1-2.5 µm wavelength range





WHY SHORT-WAVE INFRARED DETECTORS BASED ON QDS?

More Applications:

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- Enhanced vision (night vision, through fog)
- Hyperspectral imaging







WHY SHORT-WAVE INFRARED DETECTORS BASED ON QDS?

Current technology:

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III-V semiconductors (extended InGaAs based)



cost limits the number of applications where these camera's / detectors can be applied (e.g. smart phone)





=> Novel approach avoiding epitaxial growth of semiconductors, integration on 200mm/300mm silicon wafers

=> Performance of a SWIR III-V camera at the cost of a visible CMOS camera?





COLLOIDAL QUANTUM DOTS FOR SWIR?



0.3 nm



Small box

Confining electrons

(In practice a semiconductor nanocrystal)

1-1000 nm sized particle dispersed in a continuous medium

(1-20nm for quantum dots)



LOW COST THROUGH THE HOT INJECTION SYNTHESIS



Hot-injection based QD synthesis



SPECTRAL TUNABILITY THROUGH QUANTUM CONFINEMENT EFFECT





EASY HETEROGENEOUS INTEGRATION ON SI/SOI



Spin coating



Doctor blading



APPLICATIONS BASED ON COLLOIDAL QUANTUM DOTS



Introduction

- SWIR/MWIR colloidal quantum dot photodetectors
- Measurement results
- Conclusion and future work

OUTLINE



How to realize photodetection?



Gain = carrier lifetime / carrier transit time



Filling of trap states reduces responsivity at higher input power

CHALLENGES OF INTEGRATION?

Isolating organics



• Film cracking due to significant volume loss during ligand exchange



- Patterning of colloidal QD film
- Stability issues (oxidation, etc.)
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QUANTUM DOT FILMS FORMED THROUGH DIP COATING



80 mm/min withdrawal speed and 100 nM concentration

20.0 nm

18.0

16.0

14.0

12.0

10.0

8.0

6.0

4.0

2.0

0.0



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20 mm/min withdrawal speed and 1 μ M concentration



80 mm/min withdrawal speed and 1 μ M concentration



INORGANIC LIGAND EXCHANGE

FTIR measurement:

S²⁻ ligand exchange

OH⁻ ligand exchange

no exchange 0.01 mg/mL, 10 s

Intensity (a.u.)

3500

3250

Absorption

0.01 mg/mL, 30 s

0.1 mg/mL, 10



TEM measurement:

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PbS-OlAc QDs





3000

wavenumber (cm⁻¹)

2750

2500



A thorough cleaning is also needed



OH⁻ ligand exchange



LAYER-BY-LAYER ASSEMBLY METHOD



PATTERNING OF NANOCRYSTAL FILM BY WET ETCHING

Process flow:

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C. Hu, et al. "The micropatterning of layers of colloidal quantum dots with inorganic ligands using selective wet etching" Nanotechnology **2014**

MICROPATTERNING OF PBS NANOCRYSTAL FILM ON 2D SUBSTRATES

HCl/H₃PO₄ mixture with 1:10 volume ratio



PbS/S²⁻ QD film

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CdSe/CdS QD film



The etching rate for PbS/S²⁻ and PbS/OH⁻ films is ~ 40 nm/min and 45 nm/min, respectively

MICROPATTERNING OF PBS NANOCRYSTAL FILM ON 2D SUBSTRATES

Any effect of lithography/patterning on original morphology of the film?

PbS/S²⁻ QD film

PbS/OH⁻ QD film



Effect by lithography/patterning is not obvious and can be neglected!

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MICROPATTERNING OF PBS NANOCRYSTAL FILM ON 3D SUBSTRATES

SEM measurement of 3D Si substrates:

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Micropatterned PbS/OH⁻ films on 3D Si substrates and waveguides



PATTERNING OF PBS NANOCRYSTAL FILM ON PHOTODETECTOR





Introduction

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CHARACTERIZATION OF PBS QD PHOTODETECTOR



DETECTOR CHARACTERIZATION WITH FTIR



PbS QD photodetector

HgTe Photodetector: pushing the cut-off wavelength



Spectral response curves nearly match the quantum-confined absorption spectrum With OH⁻ ligand exchange, the HgTe QD photodetector has 3 time higher responsivity than dodecanethiolcapped QDs.

Collaboration with Univ Linz



PASSIVATION WITH ATOMIC LAYER DEPOSITION (ALD)

Problem: Degradation of the photodetector due to oxidization



PbS/S²⁻ QD detector (15 LBL)



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CHARACTERIZATION ON ALD COATED PBS QD FILM

X-ray photoelectron spectroscopy measurement

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After direct ALD passivation, both dark current/photocurrent are quenched, this can be attributed to alumina penetration during ALD process

CHARACTERIZATION OF PBS QD-ALD PHOTODETECTOR (I)



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PbS/S²⁻ QD photodetector

PbS/OH⁻ QD photodetector



CHARACTERIZATION OF PBS QD-ALD PHOTODETECTOR (II)



Responsivity vs. Optical Illumination



Electrical Frequency Response



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The corresponding specific detectivity is $\sim 3.4 \times 10^8$ Jones at 300K.

The 3-dB bandwidth of the PbS/S²⁻ and PbS/OH⁻ photodetectors is 40 Hz and 11 Hz, respectively.

C. Hu, et al. Applied Physics Letters 2014

CAN WE IMPROVE PHOTOCURRENT QUENCHING DURING ALD?

A sacrificial layer with large band gap material before ALD

Route 1: ZnSe QD film as sacrificial layer

Without S²⁻ exchange



Without ligand exchange, ZnSe film is not compatible with ALD growth

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With S²⁻ exchange



ZnSe QD film peeled off during ligand exchange procedure.

CAN WE IMPROVE PHOTOCURRENT QUENCHING DURING **ALD**?

Route 2: HfO₂-S²⁻ QD film as sacrificial layer exhibits ALD compatibility



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PBS PHOTOTRANSISTOR WITH **HFO**₂ SACRIFICIAL LAYER



PbS-OH⁻/HfO₂-S²⁻ QD detector (15 LBL)



PHOTOTRANSISTOR MEASUREMENT: PBS/S²⁻ QD





- S²⁻ terminated PbS QD transistors behave as p-type,
- Quasi-linear I_{sp} -V_p curves without saturation of I_{SD} , suggesting large hole densities in the FET channel and can not easily be modulated by gate voltage
- After ALD passivation, PbS-S²⁻ QD transistors • behave as ambipolar
- With HfO₂ sacrificial layer, device exhibit p-• type again, Calculated holes linear mobility $\mu_{lin} \simeq 0.025 \text{ cm}^2/(V \cdot s) @ 5V$

CHARACTERIZATION OF PBS/S²⁻ PHOTOTRANSISTOR



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- At 5 V Drain bias, 110 μW/cm² incident power, responsivity ~ 930 A/W @ -100 V gate voltage for PbS/S²⁻ phototransistor;
- The 3-dB bandwidth @ -100 V and @ 100 V gate voltage of the PbS/S²⁻ phototransistors is 3 Hz and 19 Hz, respectively.

CHARACTERIZATION OF PBS/OH⁻ **PHOTOTRANSISTOR**



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- At 5 V Drain bias, 110 μW/cm² incident power, responsivity ~ 230 A/W @ -100 V gate voltage for PbS/OH⁻ phototransistor;
- The 3-dB bandwidth @ -100 V and @ 100 V gate voltage of the PbS/S²⁻ phototransistors is 12 Hz and 17 Hz, respectively.



• Crack-free, homogeneous quantum dot films were obtained through a layerby-layer deposition approach with solid-state ligand exchange

• High resolution colloidal QD films with feature dimensions down to 500 nm can be realized through optical lithography and selective wet etching method for large scale integration applications

• Air-stable PbS colloidal QD photodetectors and phototransistors on Si with high responsivity were obtained



CAN WE FURTHER ENHANCE THE SENSITIVITY?

Increase the absorption of light in the thin film
⇒ silicon resonant grating structures
⇒ doped grating



• Enhance the mobility in the film to enhance the internal gain: QD + graphene or "artificial graphene"



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